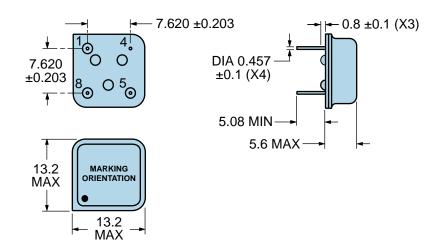


| ELECTRICAL SPECIFICATIONS             |   |  |
|---------------------------------------|---|--|
| Nominal Frequency                     | 2.500MHz  |  |
| Frequency Tolerance/Stability         | ±100ppm Maximum (Inclusive of all conditions: Calibration Tolerance at 25°C, Frequency Stability over the Operating Temperature Range, Supply Voltage Change, Output Load Change, First Year Aging at 25°C, Shock, and Vibration) |  |
| Aging at 25°C                         | ±5ppm/year Maximum  |  |
| Operating Temperature Range           | -40°C to +85°C  |  |
| Supply Voltage                        | 5.0Vdc ±10%   |  |
| Input Current                         | 45mA Maximum  |  |
| Output Voltage Logic High (Voh)       | 2.4Vdc Minimum with TTL Load, Vdd-0.5Vdc Minimum with HCMOS Load  |  |
| Output Voltage Logic Low (Vol)        | 0.4Vdc Maximum with TTL Load, 0.5Vdc Maximum with HCMOS Load  |  |
| Rise/Fall Time                        | 6nSec Maximum (Measured at 0.4Vdc to 2.4Vdc with TTL Load; Measured at 20% to 80% of waveform with HCMOS Load)  |  |
| Duty Cycle                            | 50 ±5(%) (Measured at 1.4Vdc)   |  |
| Load Drive Capability                 | 10TTL Load or 50pF HCMOS Load Maximum   |  |
| Output Logic Type                     | CMOS  |  |
| Pin 1 Connection                      | Tri-State (High Impedance)  |  |
| Tri-State Input Voltage (Vih and Vil) | +2.2Vdc Minimum to enable output, +0.8Vdc to disable output (High Impedance), No connect to enable output.  |  |
| Absolute Clock Jitter                 | ±100pSec Maximum  |  |
| One Sigma Clock Period Jitter         | ±25pSec Maximum   |  |
| Start Up Time                         | 10mSec Maximum  |  |
| Storage Temperature Range             | -55°C to +125°C   |  |

| ENVIRONMENTAL & MECHANICAL SPECIFICATIONS |                                       |  |
|---|---------------------------------------|--|
| Fine Leak Test                            | MIL-STD-883, Method 1014, Condition A |  |
| Gross Leak Test                           | MIL-STD-883, Method 1014, Condition C |  |
| Lead Integrity                            | MIL-STD-883, Method 2004              |  |
| Mechanical Shock                          | MIL-STD-202, Method 213, Condition C  |  |
| Resistance to Soldering Heat              | MIL-STD-202, Method 210               |  |
| Resistance to Solvents                    | MIL-STD-202, Method 215               |  |
| Solderability                             | MIL-STD-883, Method 2003              |  |
| Temperature Cycling                       | MIL-STD-883, Method 1010              |  |
| Vibration                                 | MIL-STD-883, Method 2007, Condition A |  |



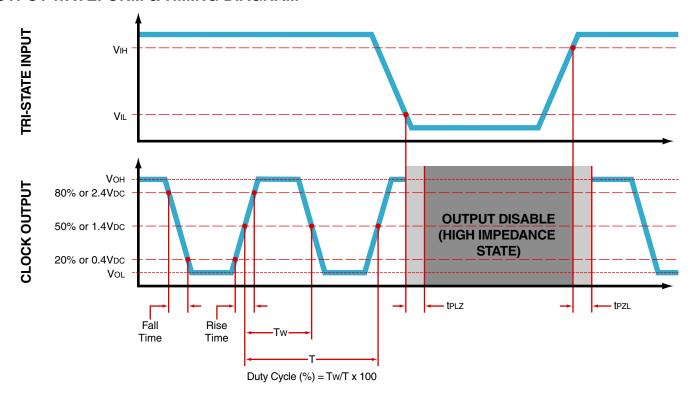
#### **MECHANICAL DIMENSIONS (all dimensions in millimeters)**



| PIN | CONNECTION                 |
|-----|----------------------------|
| 1   | Tri-State (High Impedance) |
| 4   | Case Ground                |
| 5   | Output                     |
| 8   | Supply Voltage             |

| LINE | MARKING   |
|------|---|
| 1    | ECLIPTEK  |
| 2    | EC11TS<br>EC11=Product Series   |
| 3    | 2.500M  |
| 4    | XXYZZ XX=Ecliptek Manufacturing Code Y=Last Digit of Year ZZ=Week of Year |

#### **OUTPUT WAVEFORM & TIMING DIAGRAM**





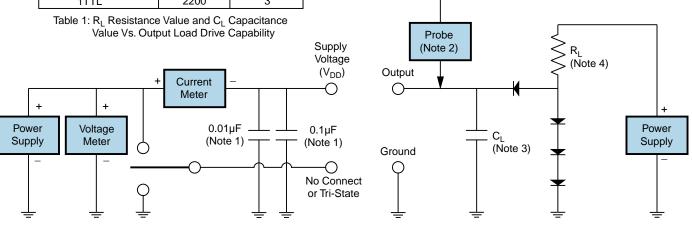
Frequency

Counter

Oscilloscope

#### **Test Circuit for TTL Output**

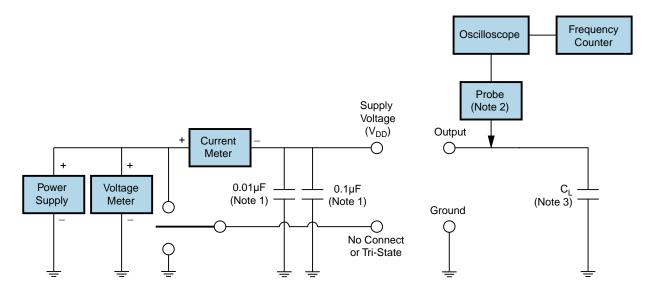
| Output Load<br>Drive Capability | R <sub>L</sub> Value<br>(Ohms) | C <sub>L</sub> Value<br>(pF) |
|---------------------------------|--------------------------------|------------------------------|
| 10TTL                           | 390                            | 15                           |
| 5TTL                            | 780                            | 15                           |
| 2TTL                            | 1100                           | 6                            |
| 10LSTTL                         | 2000                           | 15                           |
| 1TTL                            | 2200                           | 3                            |



- Note 1: An external  $0.1\mu F$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu F$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.
- Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.
- Note 3: Capacitance value  $C_L$  includes sum of all probe and fixture capacitance.
- Note 4: Resistance value R<sub>L</sub> is shown in Table 1. See applicable specification sheet for 'Load Drive Capability'.
- Note 5: All diodes are MMBD7000, MMBD914, or equivalent.



#### **Test Circuit for CMOS Output**



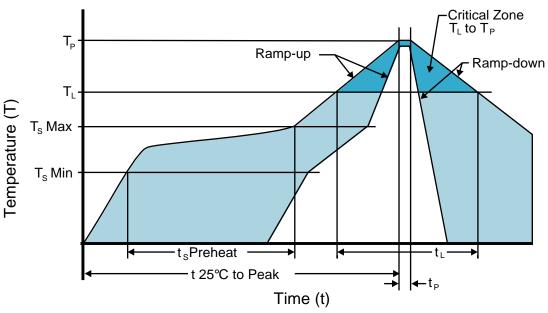
Note 1: An external  $0.1\mu F$  low frequency tantalum bypass capacitor in parallel with a  $0.01\mu F$  high frequency ceramic bypass capacitor close to the package ground and  $V_{DD}$  pin is required.

Note 2: A low capacitance (<12pF), 10X attenuation factor, high impedance (>10Mohms), and high bandwidth (>300MHz) passive probe is recommended.

Note 3: Capacitance value  $\dot{C}_L$  includes sum of all probe and fixture capacitance.



### **Recommended Solder Reflow Methods**

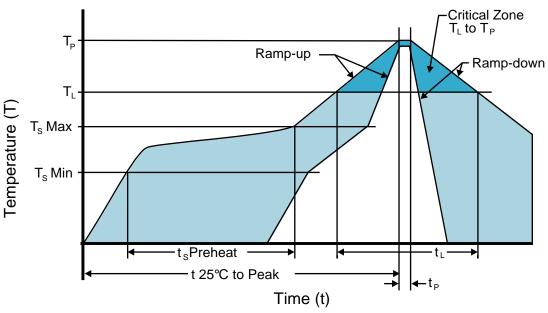


### **High Temperature Solder Bath (Wave Solder)**

|   | ,                                    |
|---|--------------------------------------|
| T <sub>s</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 3°C/second Maximum                   |
| Preheat   |                                      |
| - Temperature Minimum (T <sub>S</sub> MIN)          | 150°C                                |
| - Temperature Typical (T <sub>s</sub> TYP)          | 175°C                                |
| - Temperature Maximum (T <sub>s</sub> MAX)          | 200°C                                |
| - Time (ts MIN)                                     | 60 - 180 Seconds                     |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )    | 3°C/second Maximum                   |
| Time Maintained Above:                              |                                      |
| - Temperature (T∟)                                  | 217°C                                |
| - Time (t∟)   | 60 - 150 Seconds                     |
| Peak Temperature (T <sub>P</sub> )                  | 260°C Maximum for 10 Seconds Maximum |
| Target Peak Temperature (T <sub>P</sub> Target)     | 250°C +0/-5°C                        |
| Time within 5°C of actual peak (tp)                 | 20 - 40 seconds                      |
| Ramp-down Rate                                      | 6°C/second Maximum                   |
| Time 25°C to Peak Temperature (t)                   | 8 minutes Maximum                    |
| Moisture Sensitivity Level                          | Level 1                              |
|   |                                      |



### **Recommended Solder Reflow Methods**

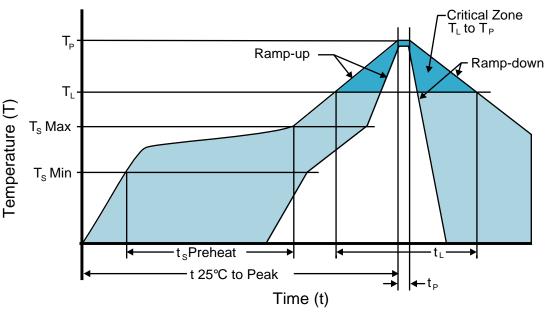


### Low Temperature Infrared/Convection 185°C

| T <sub>S</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 5°C/second Maximum         |
|---|----------------------------|
| Preheat   |                            |
| - Temperature Minimum (T <sub>S</sub> MIN)          | N/A                        |
| - Temperature Typical (T <sub>s</sub> TYP)          | 150°C                      |
| - Temperature Maximum (T <sub>s</sub> MAX)          | N/A                        |
| - Time (t <sub>s</sub> MIN)                         | 60 - 120 Seconds           |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )    | 5°C/second Maximum         |
| Time Maintained Above:                              |                            |
| - Temperature (T∟)                                  | 150°C                      |
| - Time (t∟)   | 200 Seconds Maximum        |
| Peak Temperature (T <sub>P</sub> )                  | 185°C Maximum              |
| Target Peak Temperature (T <sub>P</sub> Target)     | 185°C Maximum 2 Times      |
| Time within 5°C of actual peak (tp)                 | 10 seconds Maximum 2 Times |
| Ramp-down Rate                                      | 5°C/second Maximum         |
| Time 25°C to Peak Temperature (t)                   | N/A                        |
| Moisture Sensitivity Level                          | Level 1                    |
|   |                            |



### **Recommended Solder Reflow Methods**



#### Low Temperature Solder Bath (Wave Solder)

| T <sub>S</sub> MAX to T <sub>L</sub> (Ramp-up Rate) | 5°C/second Maximum                                    |
|---|---|
| Preheat   |   |
| - Temperature Minimum (T <sub>s</sub> MIN)          | N/A   |
| - Temperature Typical (T <sub>S</sub> TYP)          | 150°C   |
| - Temperature Maximum (T <sub>s</sub> MAX)          | N/A   |
| - Time (t <sub>s</sub> MIN)                         | 30 - 60 Seconds                                       |
| Ramp-up Rate (T <sub>L</sub> to T <sub>P</sub> )    | 5°C/second Maximum                                    |
| Time Maintained Above:                              |   |
| - Temperature (T∟)                                  | 150°C   |
| - Time (t∟)   | 200 Seconds Maximum                                   |
| Peak Temperature (T <sub>P</sub> )                  | 245°C Maximum   |
| Target Peak Temperature (T <sub>P</sub> Target)     | 245°C Maximum 1 Time / 235°C Maximum 2 Times          |
| Time within 5°C of actual peak (tp)                 | 5 seconds Maximum 1 Time / 15 seconds Maximum 2 Times |
| Ramp-down Rate                                      | 5°C/second Maximum                                    |
| Time 25°C to Peak Temperature (t)                   | N/A   |
| Moisture Sensitivity Level                          | Level 1   |

### Low Temperature Manual Soldering

185°C Maximum for 10 seconds Maximum, 2 times Maximum.

#### **High Temperature Manual Soldering**

260°C Maximum for 5 seconds Maximum, 2 times Maximum.